

SSC8119GS1

P-Channel Enhancement Mode MOSFET

> Features

VDS	VGS	RDSON Typ.	ID	
	±12V	11mR@-4V5		
-16V		16mR@-2V5	-14A	
		20mR@-1V8		

> Description

This device is produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage power management requiring a wild range of given voltage ratings such as load switch and battery protection.

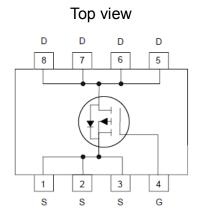
Applications

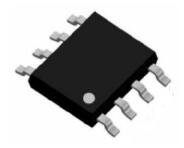
- Load Switch
- NB Battery
- DCDC conversion

> Ordering Information

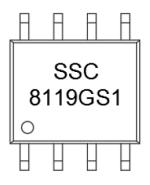
Device	Package	Shipping		
SSC8119GS1	SOP8	2500/Reel		

Pin configuration





SOP8



Marking



> **Absolute Maximum Ratings**(T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V_{DSS}	Drain-to-Source Voltage	-16	V	
V_{GSS}	Gate-to-Source Voltage	±12	V	
I _D	Continuous Drain Current ^a	-14	А	
I _{DM}	Pulsed Drain Current ^b	-39	А	
PD	Power Dissipation °	5	W	
P _{DSM}	Power Dissipation ^a	2.4	W	
TJ	Operation junction temperature	-55 to 150	°C	
T _{STG}	Storage temperature range	-55 to 150	°C	

➤ Thermal Resistance Ratings(T_A=25°C unless otherwise noted)

Symbol	Parameter	Typical	Maximum	Unit
$R_{ extsf{ heta}JA}$	Junction-to-Ambient Thermal Resistance ^a		55	°C/W
R _{θJC}	R _{0JC} Junction-to-Case Thermal Resistance		25	C/ VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with T_A=25C°. The value in any given application depends on the user is specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

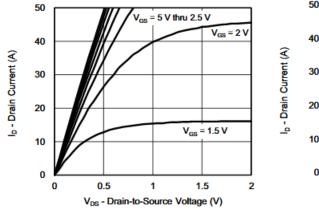


Electronics Characteristics(T_A=25°C unless otherwise noted)

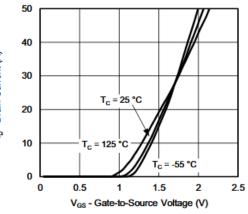
Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Unit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	VGS=0V , ID=-250uA	-16			V
$V_{GS \ (th)}$	Gate Threshold Voltage	VDS=VGS , ID=-250uA	-0.45	-0.7	-0.8	V
$R_{DS(on)}$	Drain-Source On- Resistance	VGS=-4.5V , ID=-13A		11	14	mR
		VGS=-2.5V , ID=-10A		16	20	
		VGS=-1.8V , ID=-8A		20	25	
I _{DSS}	Zero Gate Voltage Drain Current	VDS=-16V , VGS=0V			-1	uA
I _{GSS}	Gate-Source leak current	VGS=±12V , VDS=0V			±100	nA
G_{FS}	Transconductance	VDS=-5V , ID=-7A		16		S
V_{SD}	Forward Voltage	VGS=0V , IS=-1A		-0.8	-1.3	V
Ciss	Input Capacitance	VDS=-15V, VGS=0V, f=1MHZ		3000		
Coss	Output Capacitance			500		pF
Crss	Reverse Transfer Capacitance			350		
T _{D(ON)}	Turn-on delay time	VGS=-10V, VDS=-15V, ID=-5A, RG=6R		10		
Tr	Rise time			20		ns
Td(Off)	Turn-off delay time			74		
Tf	Fall time			20		



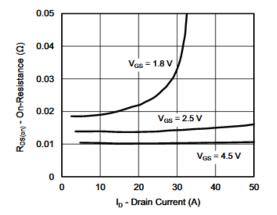
Typical Characteristics(TA=25°C unless otherwise noted) \triangleright



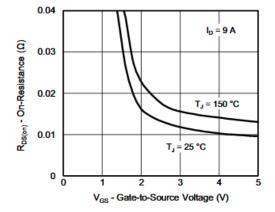
Output Characteristics



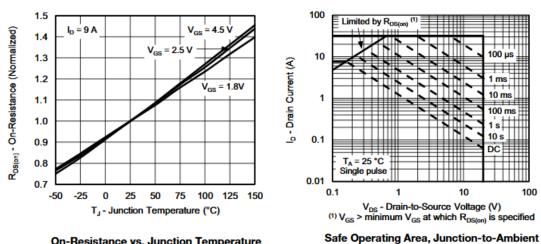
Transfer Characteristics



On-Resistance vs. Drain Current and Gate Voltage



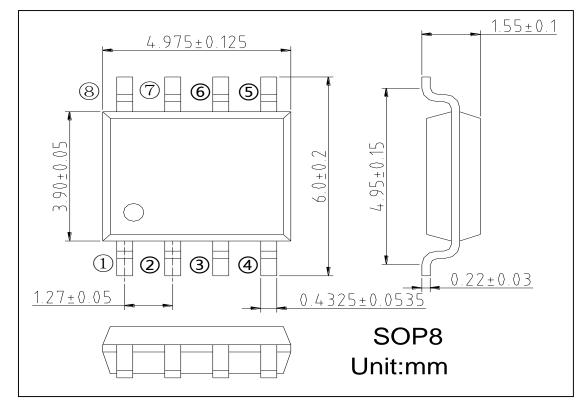
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Junction Temperature



> Package Information



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